

Notice of References Cited	Application/Control No. 10/579,097		Applicant(s)/Patent Under Reexamination AABY ET AL.	
	Examiner PINKAL R. CHOKSHI		Art Unit 2425	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-8,037,504	10-2011	Jerding et al.	725/91
*	B	US-8,032,910	10-2011	Lewis et al.	725/68
*	C	US-7,376,829	05-2008	Ranjan, Karthik	713/153
*	D	US-2007/0261089	11-2007	Aaby et al.	725/100
*	E	US-2007/0220580	09-2007	Putterman et al.	725/134
*	F	US-7,089,577	08-2006	Rakib et al.	725/87
*	G	US-2005/0091699	04-2005	Poli et al.	725/132
*	H	US-2004/0133907	07-2004	Rodriguez et al.	725/014
*	I	US-6,697,376	02-2004	Son et al.	370/465
*	J	US-6,532,591	03-2003	Arai et al.	725/132
*	K	US-2002/0059619	05-2002	Lebar, Metod	725/87
*	L	US-5,784,464	07-1998	Akiyama et al.	713/155
*	M	US-5,666,293	09-1997	Metz et al.	709/220

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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